

Notice of References Cited	Application/Control No. 09/932,086	Applicant(s)/Patent Under Reexamination FARKAS ET AL.	
	Examiner Guy J. Lamarre, P.E.	Art Unit 2133	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,510,398	01-2003	Kundu et al.	702/117
	C	US-5,872,793	02-1999	Attaway et al.	714/726
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	U	Hochbaum 'An optimal test compression procedure for combinational circuits Hochbaum,' IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems, Volume 15, Issue 10, Oct. 1996 Page(s):1294 - 1299
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.